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Fine ceramics (advanced ceramics, advanced technical ceramics) — Test method for self-cleaning performance of semiconducting photocatalytic materials under indoor lighting environment — Measurement of water contact angle

Céramiques techniques — Méthode d'essai relative aux propriétés autonettoyantes des matériaux photocatalytiques semiconducteurs dans un environnement d'éclairage intérieur — Mesurage de l'angle de contact de l'eau



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ISO copyright office
Ch. de Blandonnet 8 • CP 401
CH-1214 Vernier, Geneva, Switzerland
Tel. +41 22 749 01 11
Fax +41 22 749 09 47
copyright@iso.org
www.iso.org

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Foreword

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This document was prepared by Technical Committee ISO/TC 206, *Fine ceramics*.